# Simulation Studies of the Effect of SiPM Dark Noise on the Performance of a Highly Granular Crystal ECAL





Jack Rolph, Yong Liu, Baohua Qi, Zhiyu Zhao on behalf of the CEPC Working Group

## Overview

#### Fluence At CEPC

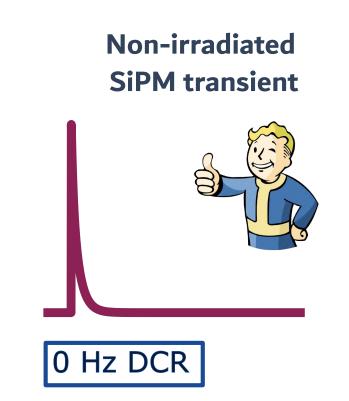
- CEPC detector will endure unprecidented fluences during operation;
- Φ ≈ 1×10 cm per year to beam pipe/at endcaps;
- Studies ongoing to reduce damage on instrumentation;

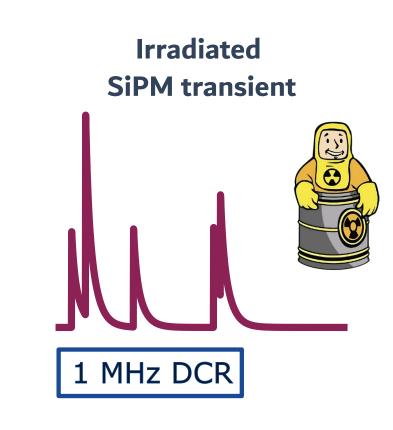
## **Highly Granular Crystal ECAL**

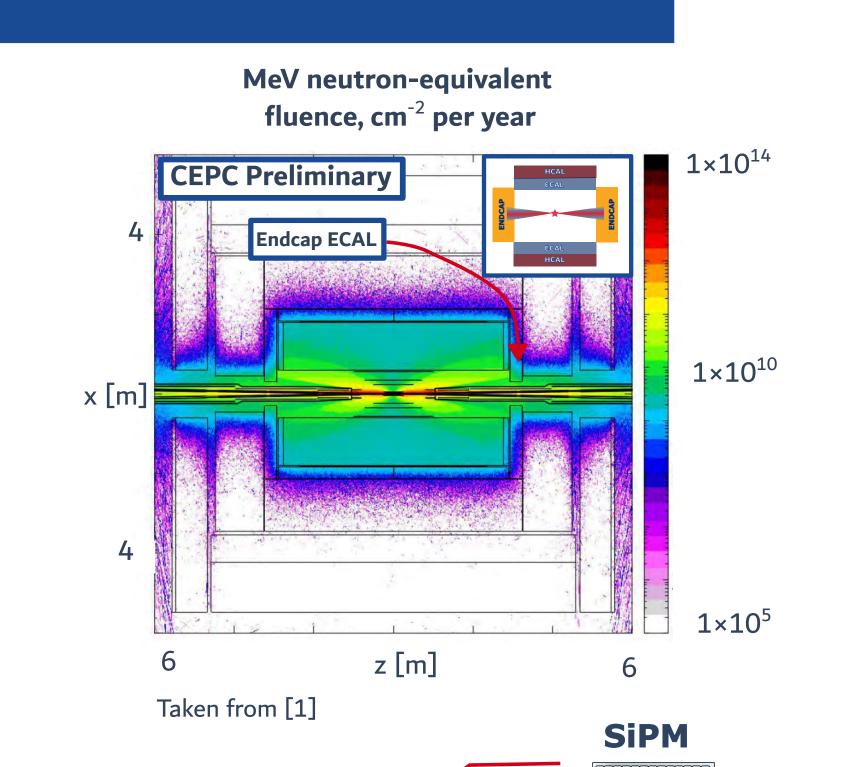
- 40 cm scintillating crystal bars (BGO, BSO) provide;
- granularity to separate individual particles;
- excellent EM energy resolution (~1-2%/GeV)
- Light signal read out by

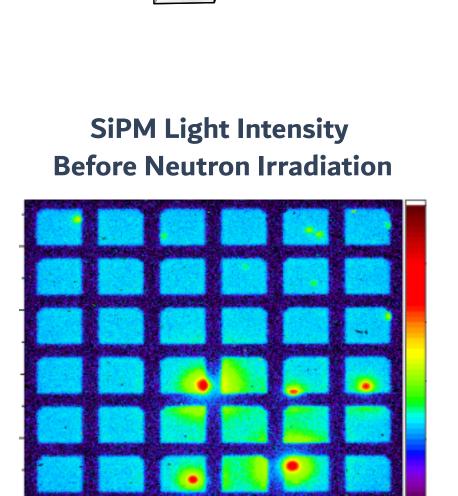
## Silicon Photomultipliers (SiPM)

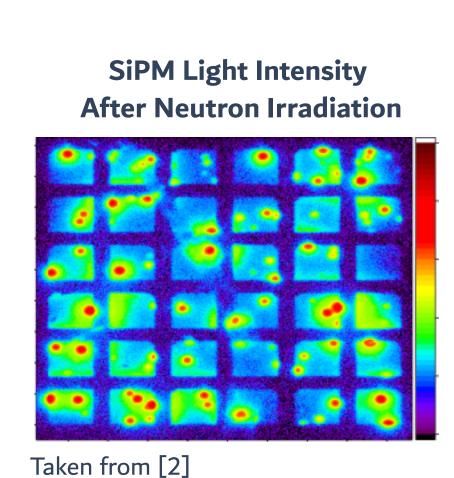
- Hadrons main source of damage for SiPMs (Non Ionising Energy Loss, NIEL);
- Crystal lattice displacement leads to defects;
- Defect-assisted trap-hole recombination → dark noise;
- Dark noise degrades calorimeter performance;
- Additional signal from 'dark counts'











Taken from [2]

## **Summary of Study**

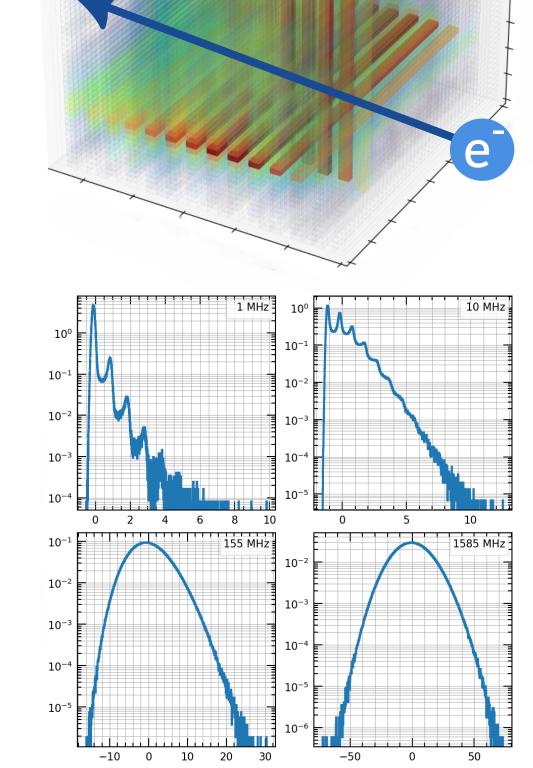
## Simulation

#### **Particle showers**

- Geant4 simulation;
- DD4HEP geometry description;
- 1 40 GeV electron showers;
- 1×10<sup>4</sup> events per sample;
- Digitisation includes cross-talk and correlated noise;

#### **Dark Noise**

- LightSimtastic SiPM simulation [2];
- DCR: 1 MHz 1.58 GHz, log scale
- 1×10<sup>7</sup> events per DCR sample;
- Resampled per event;



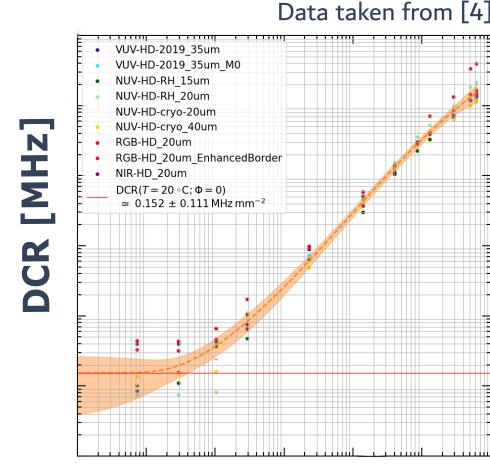
## Mean-subtracted Charge [n.p.e ]

## Analysis

- Dark noise combined with electron simulation using:
  - average crystal light yield,  $\Phi$ = 200 p.e/MIP;
  - noise threshold,  $Q_{thresh} = 0.1$  p.e;

$$Q_{ ext{Signal}+ ext{DCR}} = egin{cases} \Phi_{ ext{crystal}} imes E_{ ext{sim}} + Q_{ ext{DCR}} & ext{if } Q_{ ext{Signal}+ ext{DCR}} > Q_{ ext{thresh}} \ & ext{otherwise} \end{cases}$$

- SiPM DCR related to fluence using study of Ref. [4];
- Resolution and linearity obtained using fits of Crystal Ball distribution to reconstructed energy;



Fluence [cm]

### **Key Question:**

How does irradiation-induced dark noise degrade calorimeter resolution and linearity?

# **Key Results**

#### **Linearity of Response** Resolution Fits of $R = \frac{s}{\sqrt{E}} \oplus c \oplus \frac{n}{E}$ 1.6 1.4 -10<sup>10</sup> **EM** single-particle resolution degrades by ℤ 1.0 **Linearity for <10** - 10<sup>10</sup> ~0.5% after around -10<sup>9</sup> **GeV** showers 1×10 cm fluence degrades by up to 42% after around 0.6 1×10 cm · 10<sup>9</sup> ·108 fluence $[GeV]_{\mu}$ 0.4 10 15 50 - 10<sup>8</sup> *E* [GeV] $\chi^2/NDF=1$ λ<sup>2</sup>/NDF $10^{\circ}$ 10° $10^{1}$ $10^{10}$ $10^{7}$ $10^{9}$ 10<sup>8</sup> *E* [GeV] Fluence [cm<sup>-2</sup>]

Radiation damage of SiPMs is a critical R&D issue for this calorimeter